

## **Dr Diganta Das**



Mechanical Engineering, University of Maryland, College Park, B.Tech, Manufacturing Science and Engineering, Indian Institute of Technology) is a member of the research staff at the Center for Advanced Life Cycle Engineering.

His expertise is in reliability, environmental and operational ratings of electronic parts, up rating, electronic part reprocessing, counterfeit electronics, technology trends in the electronic parts and parts selection and management methodologies. He performs benchmarking processes and organizations of electronics companies for parts selection and management and reliability practices.

Dr. Das has published more than 50 articles on these subjects, and presented his research at international conferences and workshops. He had been the technical editor for two IEEE standards and is vice chairman of IEEE Reliability Society Standard Board coordinating two additional standards. He is an editorial board member for the journal Microelectronics Reliability and Circuit World.

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